

COMMUNICATION

Electronic Supplementary Information

Supplementary figures and tables

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Fig. S2. Photographs of 0.375 at.% Mn-doped KNN-based samples sintered at 1090 °C for 5–48 h.

Fig. S3. Photo of piezoelectric constant d_{33} value measured by two different d_{33} meters at room temperature for 0.375 at.% MnO₂-doped KNN-based single crystal.

Fig. S4. The degradation of d_{33} versus time for the Mn-doped KNN-based single crystal.

Fig. S5. Room temperature ferroelectric P-E loops of (1-x)(99.6KNN-0.4LB)-xMnO₂ crystals. (a) $x = 0$, (b) $x = 0.375\%$.

Fig. S6. (a) Room temperature powder XRD patterns (with Co-K α radiation) of (1-x)(99.6KNN-0.4LB)-xMnO₂ single crystal samples and (b) expanded XRD patterns at $2\theta = 50$ –57°.

Table S1. Comparison of piezoelectric and ferroelectric properties among developed piezoelectric ceramics and crystals.

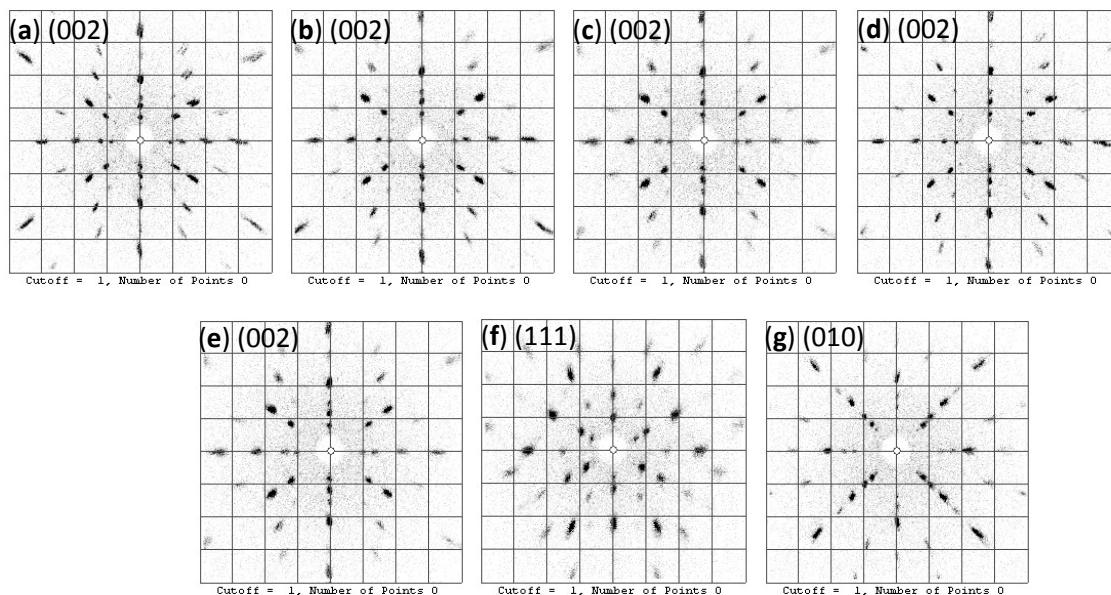


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Fig. S3. Photo of piezoelectric constant d_{33} value measured by two different d_{33} meters at room temperature for 0.375 at.% MnO₂-doped KNN-based single crystal.

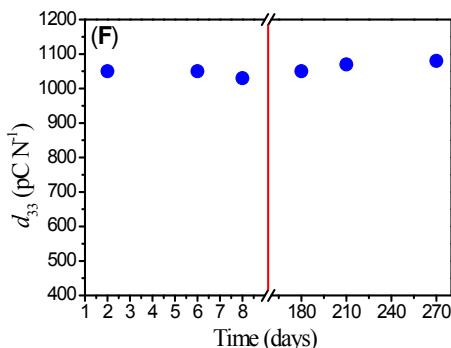


Fig. S4. The degradation of d_{33} versus time for the Mn-doped KNN-based single crystal.

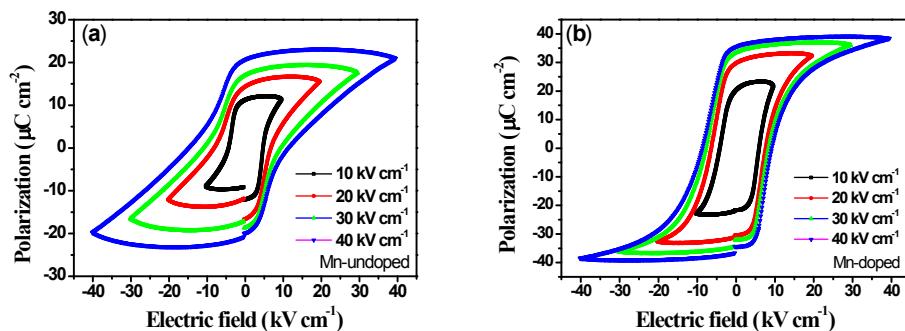


Fig. S5. Room temperature ferroelectric P-E loops of $(1-x)(99.6\text{KNN}-0.4\text{LB})-x\text{MnO}_2$ crystals. (a) $x = 0$, (b) $x = 0.375\%$.

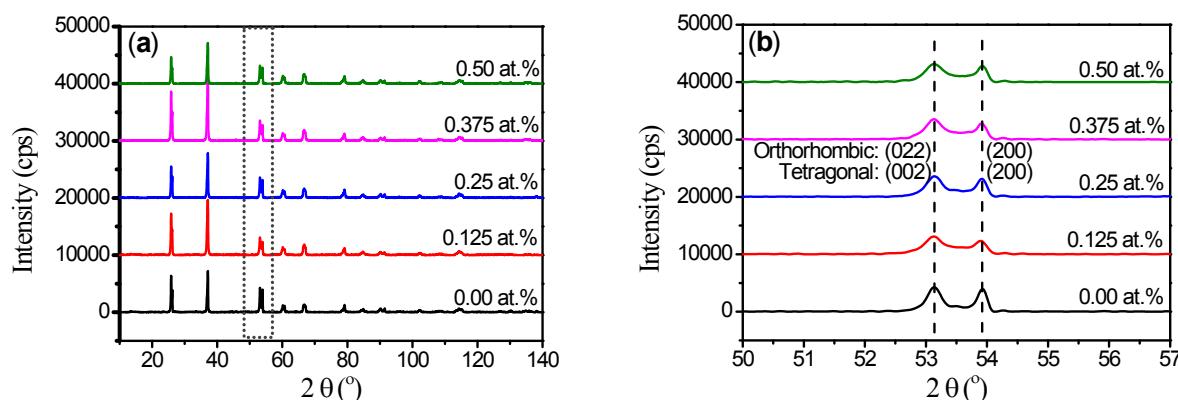


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Table S1. Comparison of piezoelectric and ferroelectric properties among developed piezoelectric ceramics and crystals.

Composition	d_{33} (pC N ⁻¹)	ε_r	T_c (°C)	Growth method
KNN-LB: Mn crystal	1050	675	403	SFSSCG(this work)
KNL4Ncrystal	689	~450	432	SFSSCG[32]
KNN-LB crystal	260	~3000	405	SFSSCG[11]
KNNTL: Mn crystal	545	362	235	TSSG[25]
KNNLiNbO ₃ crystal	405	185	426	Bridgeman[21]
KNN: Mn crystal	270	730	416	Flux[22]
Textured LF4T ceramic	416	1570	253	Textured process[6]
KNNS-BNKZ ceramic	490	>2000	227	Ceramic process[13]
KNNS-BZ-BKH	570	/	~190	Ceramic process[14]